

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10538549	KANG ET AL.
	<b>Examiner</b> Takele, Meseker	<b>Art Unit</b> 2174

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	157, 161, 169	06/28/2007	MT
715	816, 715, 711	06/28/2007	MT

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
East (US -PGPUB, USPAT, IBM_TDB)	06/28/2007	MT
Consult wit Primary Sy Luu	07/02/2007	MT
Consult with Lance Sealey (Search strategy expert)	06/28/2007	MT

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>